


<b>Search Notes</b>  	<b>Application/Control No.</b>  10796833	<b>Applicant(s)/Patent Under Reexamination</b>  LEE, WOO-JIN
	<b>Examiner</b>  Takele, Meseker	<b>Art Unit</b>  2174

SEARCHED			
Class	Subclass	Date	Examiner
715	760, 513	3/31/2008	mt
348	14.01	3/31/2008	mt

SEARCH NOTES		
Search Notes	Date	Examiner
East ( US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT)	3/31/2008	MT
Consult with Primary Sy Luu	9/4/2007	MT
Google and NPL search	3/31/2008	MT
Inventor search	3/31/2008	MT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner